

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/026,242	ZEHETNER, JOHANN	
Examiner		Art Unit		Page 1 of 1
Hien Tran		1764		

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-4,832,998	05-1989	Cyron, Theodor	428/116
B	US-5,304,351	04-1994	Tanaka et al.	422/180
C	US-5,797,183	08-1998	Humpolik et al.	422/180
D	US-6,458,329	10-2002	Wieres, Ludwig	422/180
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
U		
V		
W		
X		

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.